onsemi

<u>Silicon Carbide (SiC)</u> <u>Cascode JFET</u> – EliteSiC, Power N-Channel, TO247-4, 1200 V, 53 mohm

UF4C120053K4S

Description

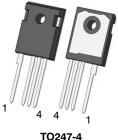
The UF4C120053K4S is a 1200 V, 53 m Ω G4 SiC FET. It is based on a unique 'cascode circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

Features

- On-resistance $R_{DS(on)}$: 53 m Ω (typ)
- Operating Temperature: 175 °C (max)
- Excellent Reverse Recovery: $Q_{rr} = 216 \text{ nC}$
- Low Body Diode V_{FSD}: 1.28 V
- Low Gate Charge: $Q_G = 37.8 \text{ nC}$
- Threshold Voltage $V_{G(th)}$: 4.8 V (typ) Allowing 0 to 15 V Drive
- Low Intrinsic Capacitance
- ESD Protected: HBM Class 2 and CDM Class C3
- TO-247-4L Package for Faster Switching, Clean Gate Waveforms
- This Device is Pb-Free, Halogen Free and is RoHS Compliant

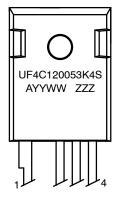
Typical Applications

- EV Charging
- PV Inverters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Motor Drives
- Induction Heating



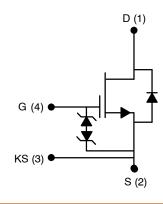
TO247-4 CASE 340AN

MARKING DIAGRAM



UF4SC120030K4S	=	Specific Device Code
Α	= ,	Assembly Location
YY	= `	Year
WW	= '	Work Week
ZZZ	=	Lot Code

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

MAXIMUM RATINGS

Parameter	Symbol	Test Conditions	Value	Unit
Drain-source Voltage	V _{DS}		1200	V
Gate-source Voltage	V _{GS}	DC	-20 to +20	V
		AC (f > 1 Hz)	-25 to +25	
Continuous Drain Current (Note 1)	۱ _D	T _C = 25 °C	34	А
		T _C = 100 °C	25	
Pulsed Drain Current (Note 2)	I _{DM}	T _C = 25 °C	100	А
Single Pulsed Avalanche Energy (Note 3)	E _{AS}	L = 15 mH, I _{AS} = 2.7 A	54.6	mJ
SiC FET dv/dt Ruggedness	dv/dt	$V_{DS} \le 800 \text{ V}$	150	V/ns
Power Dissipation	P _{tot}	T _C = 25 °C	263	W
Maximum Junction Temperature	T _{J, max}		175	°C
Operating and Storage Temperature	T _J , T _{STG}		–55 to 175	°C
Max. Lead Temperature for Soldering, 1/8" from Case for 5 seconds	ΤL		250	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Limited by $T_{J, max}$. 2. Pulse width t_p limited by $T_{J, max}$. 3. Starting $T_J = 25$ °C.

THERMAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$		-	0.44	0.57	°C/W

ELECTRICAL CHARACTERISTICS (T_J = +25 °C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
TYPICAL PERFORMANCE - STATIC						
Drain-source Breakdown Voltage	BV _{DS}	$V_{GS} = 0 V, I_D = 1 mA$	1200	-	-	V
Total Drain Leakage Current	I _{DSS}	V_{DS} = 1200 V, V_{GS} = 0 V, T_{J} = 25 $^{\circ}C$	-	0.2	50	μΑ
		$V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 175^{\circ}\text{C}$	-	15	_	
Total Gate Leakage Current	I _{GSS}		-	6	20	μΑ
Drain-source On-resistance	R _{DS(on)}	V_{GS} = 12 V, I _D = 20 A, T _J = 25°C	-	53	67	mΩ
		V_{GS} = 12 V, I _D = 20 A, T _J = 125°C	-	112	-	1
		V_{GS} = 12 V, I _D = 20 A, T _J = 175°C	-	159	-	1
Gate Threshold Voltage	V _{G(th)}	V _{DS} = 5 V, I _D = 10 mA	4	4.8	6	V
Gate Resistance	R _G	f = 1 MHz, open drain	-	4.5	-	Ω

Diode Continuous Forward Current (Note 1)	۱ _S	$T_{C} = 25 \ ^{\circ}C$	-	-	34	А
Diode Pulse Current (Note 2)	I _{S, pulse}	$T_{C} = 25 \ ^{\circ}C$	-	-	100	А
Forward Voltage	V _{FSD}	V_{GS} = 0 V, I_S = 10 A, T_J = 175 $^\circ C$	-	1.28	1.65	V
		V_{GS} = 0 V, I _S = 10 A, T _J = 175 °C	-	1.96	-	
Reverse Recovery Charge	Q _{rr}	V_{DS} = 800 V, I _S = 25 A, V _{GS} = 0 V, R _G = 18 Ω, di/dt = 2400 A/μs,	-	216	-	nC
Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}$	-	20	-	ns
Reverse Recovery Charge	Q _{rr}	V_{DS} = 800 V, I _S = 25 A, V _{GS} = 0 V, R _G = 18 Ω, di/dt = 2400 A/μs,	-	259	_	nC
Reverse Recovery Time	t _{rr}	$T_{\rm J} = 180$ s2, di/di = 2400 A/µs, $T_{\rm J} = 150$ °C	-	22	-	ns

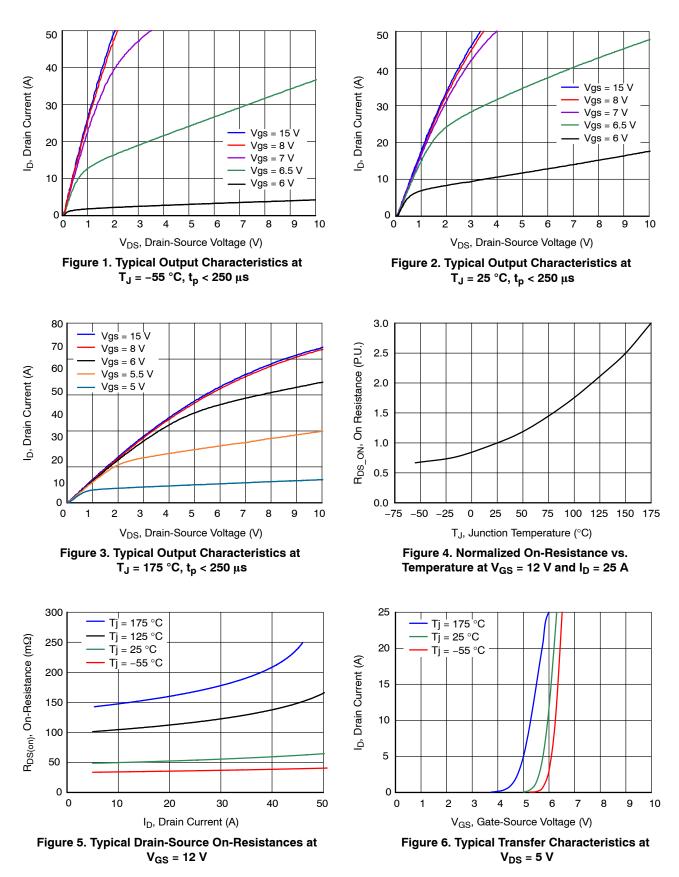
ELECTRICAL CHARACTERISTICS (T_J = +25 $^{\circ}$ C unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
TYPICAL PERFORMANCE – DYNAMIC						
Input Capacitance	C _{iss}	$V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V},$	-	1370	-	pF
Output Capacitance	C _{oss}	f = 100 kHz	-	43.5	-	
Reverse Transfer Capacitance	C _{rss}		-	2.2	-	
Effective Output Capacitance, Energy Relat- ed	C _{oss(er)}	V_{DS} = 0 V to 800 V, V_{GS} = 0 V	-	54	_	pF
Effective Output Capacitance, Time Related	C _{oss(tr)}		-	100	-	
C _{OSS} Stored Energy	E _{oss}	$V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	-	17.3	_	μJ
Total Gate Charge	Q _G	$V_{DS} = 800 \text{ V}, \text{ I}_{D} = 25 \text{ A},$	-	37.8	-	nC
Gate-drain Charge	Q _{GD}	V _{GS} = 0 V to 15 V	-	9.5	-	
Gate-source Charge	Q _{GS}		-	10	-	
Turn-on Delay Time	t _{d(on)}	(Note 4)	-	10	-	ns
Rise Time	t _r	V _{DS} = 800 V, I _D = 25 A, Gate Driver = 0 V to +15 V,	-	23	-	
Turn-off Delay Time	t _{d(off)}	$R_{G ON} = 1 \Omega$, $R_{G OFF} = 18 \Omega$,	-	79	-	
Fall Time	t _f	Inductive Load, FWD: same device with	-	12	-	
Turn-on Energy	E _{ON}	$V_{GS} = 0 V, R_G = 18 \Omega,$	-	418	-	μJ
Turn-off Energy	E _{OFF}	T _J = 25 °C	_	67	-	
Total Switching Energy	E _{TOTAL}		-	485	-	
Turn-on Delay Time	t _{d(on)}	(Note 4)	-	11	-	ns
Rise Time	tr	$ \begin{array}{l} V_{DS} = 800 \text{ V}, I_D = 25 \text{ A}, \\ \text{Gate Driver} = 0 \text{ V to } +15 \text{ V}, \\ \text{R}_{G \ ON} = 1 \ \Omega, \text{R}_{G \ OFF} = 18 \ \Omega, \\ \text{Inductive Load}, \\ \text{FWD: same device with} \\ \text{V}_{GS} = 0 \text{ V}, \text{R}_{G} = 18 \ \Omega, \end{array} $	-	26	-	
Turn-off Delay Time	t _{d(off)}		-	83	-	
Fall Time	t _f		_	14	_	
Turn-on Energy	E _{ON}		_	518	-	μJ
Turn-off Energy	E _{OFF}	$T_J = 150 \ ^{\circ}C$	-	125	-	
Total Switching Energy	E _{TOTAL}		-	643	-	
Turn-on Delay Time	t _{d(on)}	(Note 5) and (Note 6)	-	36	-	ns
Rise Time	tr	V _{DS} = 800 V, I _D = 25 A, Gate Driver = 0 V to +15 V,	-	24	-	
Turn-off Delay Time	t _{d(off)}	$R_G = 1 \Omega$, Inductive Load,	-	54	-	
Fall Time	t _f	FWD: same device with V_{GS} = 0 V and R_{G} = 1 Ω ,	_	15	-	
Turn-on Energy Including R _S Energy	E _{ON}	$V_{GS} = 0$ V and $R_G = 1.52$, RC Snubber: $Rs_1 = 5 \Omega$,	-	406	-	μJ
Turn-off Energy Including R _S Energy	E _{OFF}	Cs ₁ = 95 pF, T _J = 25 °C	-	61	-	-
Total Switching Energy	E _{TOTAL}		-	467	-	
Snubber R _S Energy During Turn-on	E _{RS_ON}		-	7	-	
Snubber R _S Energy During Turn-off	E _{RS_OFF}		_	7	_	
Turn-on Delay Time	t _{d(on)}	(Note 5) and (Note 6)	_	39	_	ns
Rise Time	tr	$V_{DS} = 800 \text{ V}, I_D = 25 \text{ A},$	-	27	-	
Turn-off Delay Time	t _{d(off)}	Gate Driver = 0 V to +15 V, $R_G = 1 \Omega$, Inductive Load,	_	55	_	
Fall Time	t _f	FWD: same device with	-	15	-	
Turn-on Energy Including R _S Energy	E _{ON}	$V_{GS} = 0 V and R_G = 1 \Omega,$ RC Snubber: Rs ₁ = 5 Ω ,	-	489	_	μJ
Turn-off Energy Including R _S Energy	E _{OFF}	Cs ₁ = 95 pF, T _J = 150 °Ć	_	83	_	
Total Switching Energy	E _{TOTAL}	1	_	572	_	
Snubber R _S Energy During Turn-on	E _{RS_ON}	1	-	6	-	
Snubber R _S Energy During Turn-off	E _{RS_OFF}	1	_	7	_	

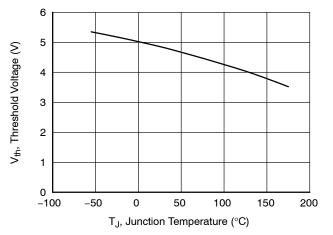
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Measured with the switching test circuit in Figure 22.
5. Measured with the switching test circuit in Figure 23.
6. All the switching energies (turn-on energy, turn-off energy and total energy) presented in this table include the device RC snubber energy losses.

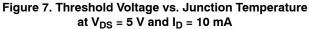
losses.

TYPICAL PERFORMANCE DIAGRAMS



TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)





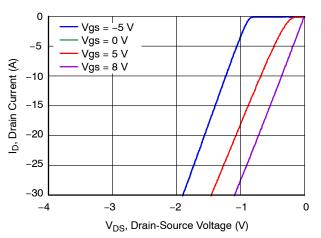


Figure 9. 3rd Quadrant Characteristics at $T_J = -55$ °C

-2

V_{DS}, Drain-Source Voltage (V)

0

-5

-10

-15

-20

-25

-30

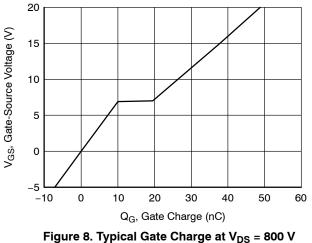
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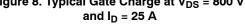
I_D, Drain Current (A)

Vgs = −5 V Vgs = 0 V

Vgs = 5 V Vgs = 8 V

-3





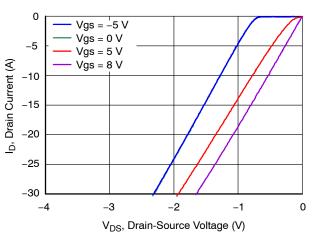
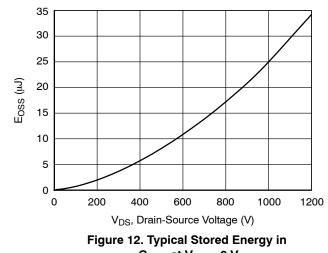


Figure 10. 3rd Quadrant Characteristics at T_J = 25 °C



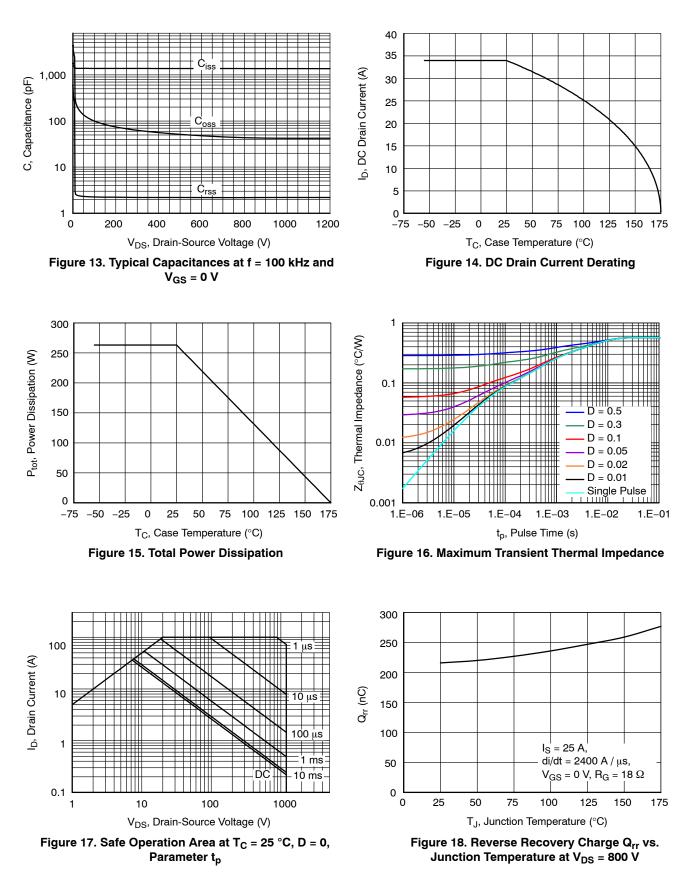
 C_{OSS} at $V_{GS} = 0$ V

Figure 11. 3rd Quadrant Characteristics at T_J = 175 °C

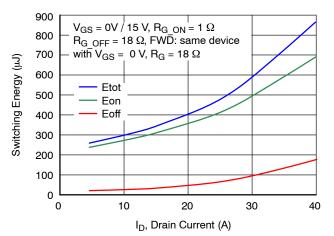
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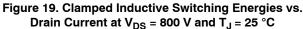
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TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)



TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)





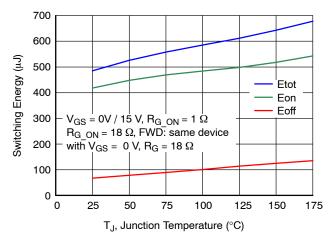


Figure 21. Clamped Inductive Switching Energies vs. Junction Temperature at V_{DS} = 800 V and I_D = 25 A

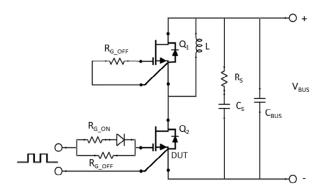


Figure 22. Schematic of the Half-Bridge Mode Switching Test Circuit. A Bus RC Snubber ($R_S = 2.5 \Omega$, $C_S = 100 nF$) is Used to Reduce the Power Loop High Frequency Oscillations

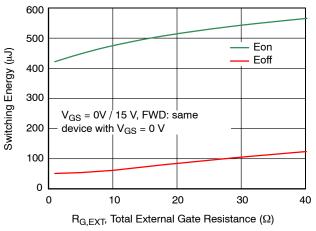


Figure 20. Clamped Inductive Switching Energies vs. $R_{G,EXT}$ at V_{DS} = 800 V, I_D = 25 A, and T_J = 25 °C

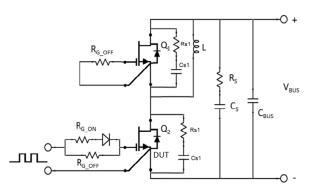


Figure 23. Schematic of the Half-Bridge Mode Switching Test Circuit with Device RC Snubber ($R_{S1} = 5 \Omega$, $C_{S1} = 95 pF$) and a Bus RC Snubber ($R_S = 2.5 \Omega$, $C_S = 100 nF$)

APPLICATIONS INFORMATION

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{rr}) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is

working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see <u>www.onsemi.com</u>.

A snubber circuit with a small $R_{(G)}$, or gate resistor, provides better EMI suppression with higher efficiency compared to using a high $R_{(G)}$, value. There is no extra gate delay time when using the snubber circuitry, and a small $R_{(G)}$, will better control both the turn-off $V_{(DS)}$ peak spike and ringing duration, while a high $R_{(G)}$ will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high $R_{(G)}$, while greatly reducing $E_{(OFF)}$ from mid-to-full load range with only a small increase in $E_{(ON)}$. Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the **onsemi** website at <u>www.onsemi.com</u>.

ORDERING INFORMATION

Part Number	Marking	Package	Shipping
UF4C120053K4S	UF4C120053K4S	TO247-4	600 Units / Tube

REVISION HISTORY

Revision	Description of Changes	Date
В	Acquired the original Qorvo JFET Division Data Sheet and updated the main document title to comply with onsemi standards for SiC products.	1/15/2025
3	Converted the Data Sheet to onsem i format.	04/30/2025

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3 2

2.21

DATE 20 JUN 2025

D2

D1

E1

MAX

5.31

2.59

2.49

1.40

2.39

0.89

21.46

_ 1.35

16.26

millimeters

NOM

5.03

2.40

2.03

1.20

2.03

0.60

20.96

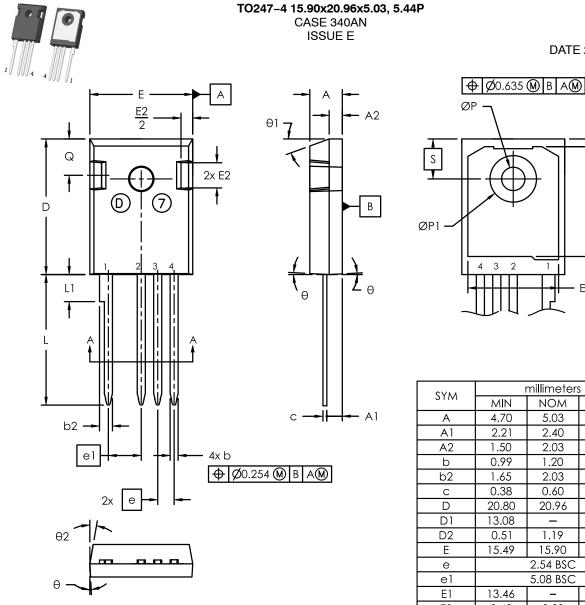
_

1.19

15.90

E / DC

10°



NOTE:

- 1. Dimensioning and tolerancing as per ASA
- 2. Controlling dimension : millimeters
- 3. Package Outline in compliance with . AD.
- Dimensions D & E does not include mold 4.
- ØP to have max draft angle of 1.7° to th 5. diameter of 3.91mm.
- Through Hole diameter value = End Hole diameter 5.
- PCB Through Hole pattern as per IPC-2221/IPC-2222 6.

	e	e 2.54 BSC			
	el		5.08 BSC		
	E1	13.46	1	-	
	E2	3.43	3.89	5.20	
ME Y14.5 - 2018	L	19.81	20.17	20.32	
1012 114.0 2010	L1	-	1	4.50	
JEDEC standard var.	ØP	3.40	3.60	3.80	
	ØP1	7.06	7.19	7.39	
l flash.	Q	5.38	5.62	6.20	
he top with max. hole	S		6.17 BSC		
-	θ 3°				
e diameter	θ1		20°		

θ2

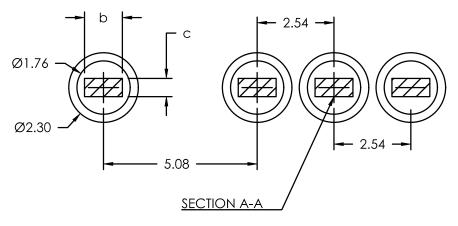
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DATE 20 JUN 2025

RECOMMENDED PCB THROUGH HOLE



NOTE: LAND PATTERN AND THROUGH HOLE DIMENSIONS SERVE ONLY AS AN INITIAL GUIDE. END-USER PCB DESIGN RULES AND TOLERANCES SHOULD ALWAYS PREVAIL.

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